Application/Control No. Applicant(s)/Patent Under Reexamination 10/630,003 LI, KE-YI Notice of References Cited Art Unit Examiner Page 1 of 1 Lien T. Tran 1761 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Ε US-F US-G USн US-US-US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Classification Name Country Code-Number-Kind Code MM-YYYY Jpo2001178386A 07-2001 Yutaka Japan Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** * Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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